

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination TAKEUCHI ET AL.	
		Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,184,610	02-2001	Shibata et al.	313/309
	C	US-6,025,819	02-2000	Xie et al.	345/75.1
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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